FORM PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				Arry. Docker No. 80839DMW			Serial No.	
If AFTER the later date of the first Office Action				Applicant:				Ta &
or 3 months from filing, use only with Rule 97(E)				Andrew C. Gallagher				<u>"</u> ⊗ <b>≡</b> 8
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U.S. PATENT DOCUMENTS								
Examiner Initial*	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLA	SS	FILING DATE  IF APPROPRIATE
BG	3,971,065	7/20/76	Bryce E. Bayer		358	41		3/5/75
BG	4,667,092	5/19/87	Yasuo Ishihara		250	216		12/22/83
Bo	5,012,333	4/30/91	Hsi	Hsien-Che Lee et al.		80		1/5/89
BG	5,652,621	7/29/97	Jan	James E. Adams, Jr.		272		2/23/96
BG	6,040,858	3/21/00	Eiic	chiro Ikeda	348	242		11/16/95
FOREIGN PATENT DOCUMENTS								
Examiner	DOCUMENT NÜMBER	DATE		COUNTRY	CLASS	SUBCLA	ss	<u>TRANSLATION</u>
Initial*		<u> </u>			<u></u>			YES   NO
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)								
EXAMINER 12-16/03								
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Atty. Docket No. Serial No. US DEPARTMENT OF COMMERCE 80839DMW US 09/615,398 PATENT AND TRADEMARK OFF Customer No. 01333 If AFTER the later date of the first office Action Andrew C. Gallagher, et al or 3 months from filing, use only with Rule 97(E) Certificate or Fee Filing Date LIST OF ART CITED BY APPLICANT Group 2722 13 July 2000 (Use several sheets if necessary) **U.S. PATENT DOCUMENTS** CLASS SUBCLASS FILING DATE DOCUMENT NUMBER NAME Examiner IF APPROPRIATE Initial\* FOREIGN PATENT DOCUMENTS CLASS SUBCLASS TRANSLATION DOCUMENT NUMBER DATE Examiner Initial\* OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) "High Dynamic Range Imaging: Spatially Varying Pixel Exposures" by Shree K. Mayar and Tomoo Mitsunaga. IEEE Conference on Computer Vision and Pattern Recognition, Vol. I, pp. 472-479. DATE CONSIDERED EXAMINER EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance